FAIRCHILD

SEMICONDUCTOR

FQB5N50CF 500V N-Channel MOSFET

Features

- 5A, 500V, $R_{DS(on)} = 1.55 \Omega @V_{GS} = 10 V$
- Low gate charge (typical 18nC)
- Low Crss (typical 15pF)
- · Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, electronic lamp ballasts based on half bridge topology.

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Absolute Maximum Ratings

Symbol	Parameter		FQB5N50CF	Units
V _{DSS}	Drain-Source Voltage	500	V	
I _D	Drain Current - Continuous (T _C = 25°C)		5	А
	- Continuous (T _C = 100°C)	3.2	А	
I _{DM}	Drain Current - Pulsed	(Note 1)	20	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	300	mJ
I _{AR}	Avalanche Current	(Note 1)	5	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	9.6	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P _D	Power Dissipation ($T_C = 25^{\circ}C$)		96	W
	- Derate above 25°C		0.76	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
Τ _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	FQB5N50CF	Units
R_{\thetaJC}	Thermal Resistance, Junction-to-Case	1.3	°C/W
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient*	40	°C/W
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

 * When mounted on the minimum pad size recommended (PCB Mount)

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Package Marking and Ordering Information **Device Marking** Device Package **Reel Size Tape Width** Quantity FQB5N50CF FQB5N50CFTM D2-PAK 330mm 24mm 800 FQB5N50CF FQB5N50CFTF D2-PAK 330mm 24mm 800 Electrical Characteristics T_c = 25°C unless otherwise noted **Test Conditions** Symbol Parameter Min Typ Max Units Off Characteristics Drain-Source Breakdown Voltage $\mathsf{BV}_{\mathsf{DSS}}$ $V_{GS} = 0 \text{ V}, I_D = 250 \text{ }\mu\text{A}$ 500 ---V --- $\Delta BV_{DSS}/$ Breakdown Voltage Temperature Coefficient $I_D = 250 \ \mu$ A, Referenced to 25° C 0.5 ---V/°C --- $\Delta T_{.1}$ V_{DS} = 500 V, V_{GS} = 0 V Zero Gate Voltage Drain Current 10 IDSS -μΑ V_{DS} = 400 V, T_C = 125°C 100 ----μΑ V_{GS} = 30 V, V_{DS} = 0 V Gate-Body Leakage Current, Forward --100 nA I_{GSSF} Gate-Body Leakage Current, Reverse V_{GS} = -30 V, V_{DS} = 0 V -100 ---nA IGSSR On Characteristics Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \ \mu A$ 4.0 V V_{GS(th)} 2.0 -- $V_{GS} = 10 \text{ V}, I_{D} = 2.5 \text{ A}$ Static Drain-Source On-Resistance 1.3 1.55 Ω R_{DS(on)} --Forward Transconductance $V_{DS} = 40 \text{ V}, I_{D} = 2.5 \text{ A}$ --5.2 S (Note 4) -**g**fs **Dynamic Characteristics** Ciss Input Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ 480 625 pF --f = 1.0 MHz C_{oss} **Output Capacitance** 80 105 pF --**Reverse Transfer Capacitance** 15 20 C_{rss} -pF Switching Characteristics Turn-On Delay Time $V_{DD} = 250 \text{ V}, I_D = 5\text{A},$ 12 35 -ns t_{d(on)} ${\sf R}_{\sf G}$ = 25 Ω Turn-On Rise Time 46 100 tr --ns Turn-Off Delay Time 50 110 -ns t_{d(off)} (Note 4, 5) Turn-Off Fall Time t_f ---48 105 ns Qg **Total Gate Charge** $V_{DS} = 400 \text{ V}, I_{D} = 5\text{A},$ ---18 24 nC $V_{GS} = 10 V$ Q_{gs} Gate-Source Charge 2.2 nC ------ Q_{gd} Gate-Drain Charge 9.7 --nC (Note 4, 5) ---Drain-Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current 5 А ls -----Maximum Pulsed Drain-Source Diode Forward Current 20 А I_{SM} ------Drain-Source Diode Forward Voltage $V_{GS} = 0 V, I_{S} = 5 A$ V V_{SD} ----1.4 t_{rr} **Reverse Recovery Time** $V_{GS} = 0 V, I_{S} = 5 A,$ ---65 --ns $dI_{\rm F}/dt = 100 \, {\rm A}/{\rm \mu s}$ (Note 4) Reverse Recovery Charge 110 nC Q_{rr} -----

NOTES:

1. Repetitive Rating : Pulse width limited by maximum junction temperature

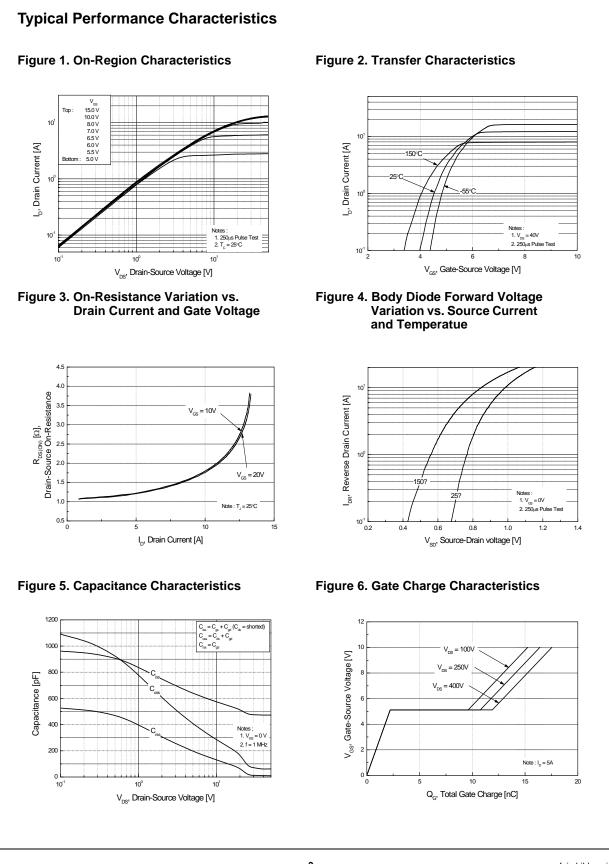
2. L = 21.5mH, I_{AS} = 5A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C

3. I_{SD} \leq 5A, di/dt \leq 200A/\mu s, V_{DD} \leq BV_{DSS,} Starting $\ T_J$ = 25°C

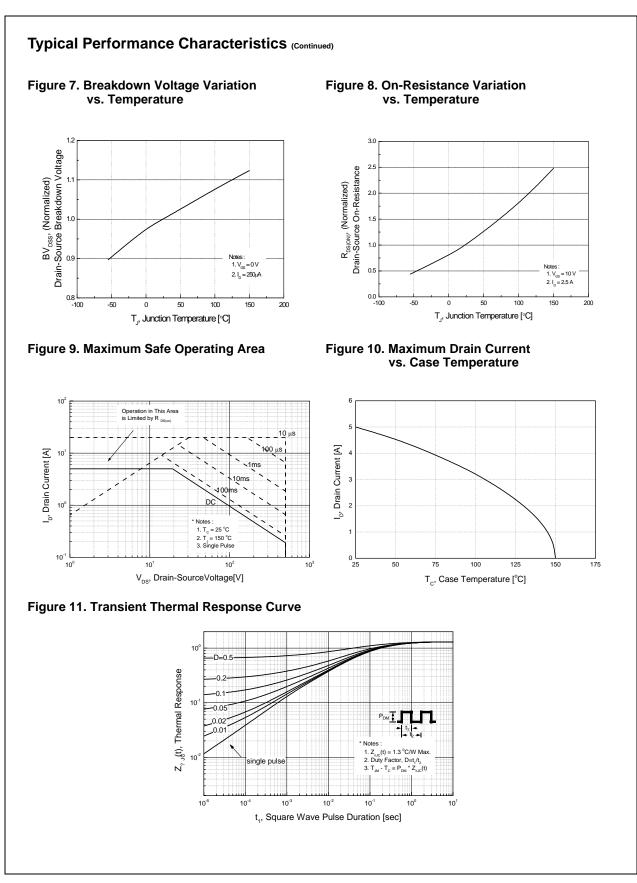
4. Pulse Test : Pulse width $\leq 300 \mu s$, Duty cycle $\leq 2\%$

5. Essentially independent of operating temperature

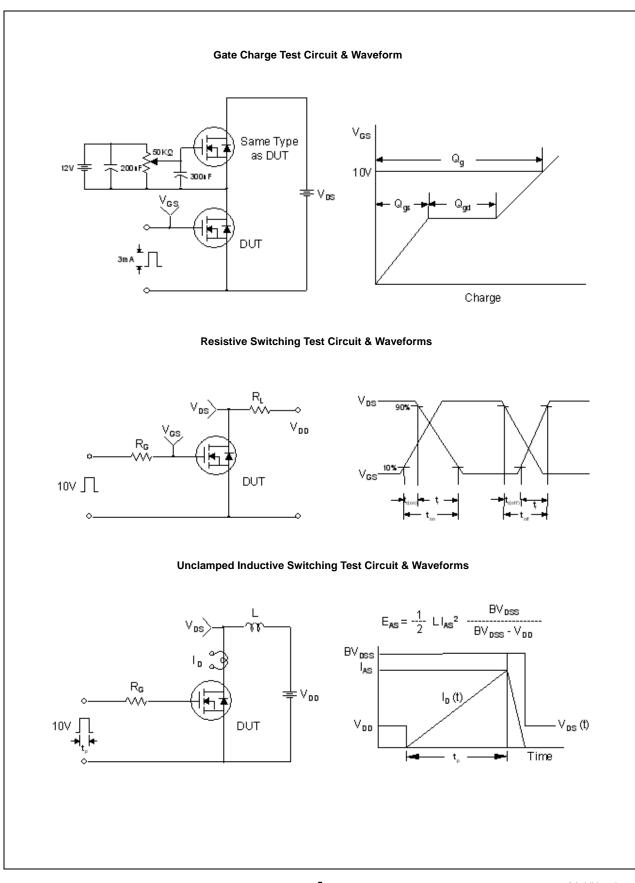
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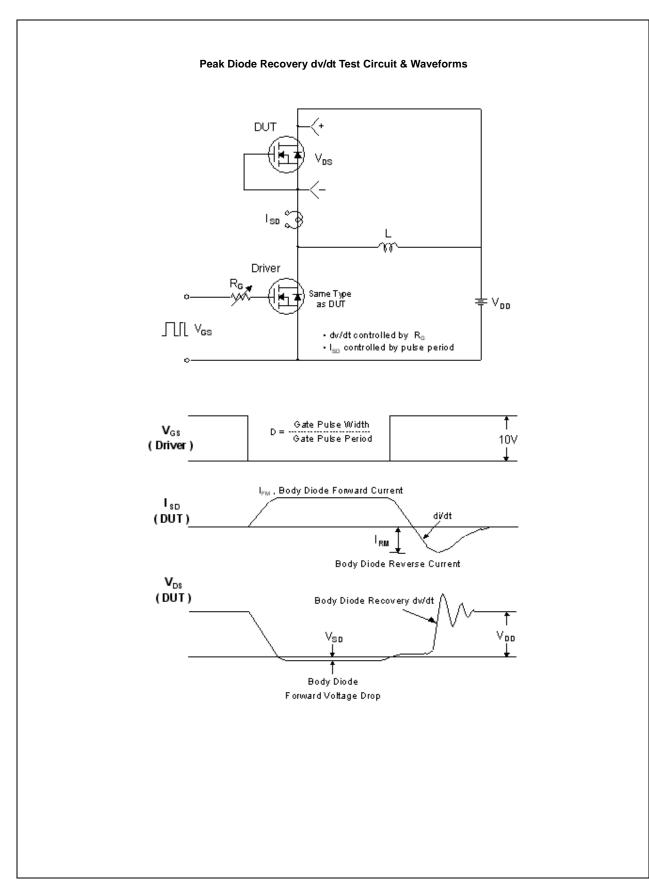
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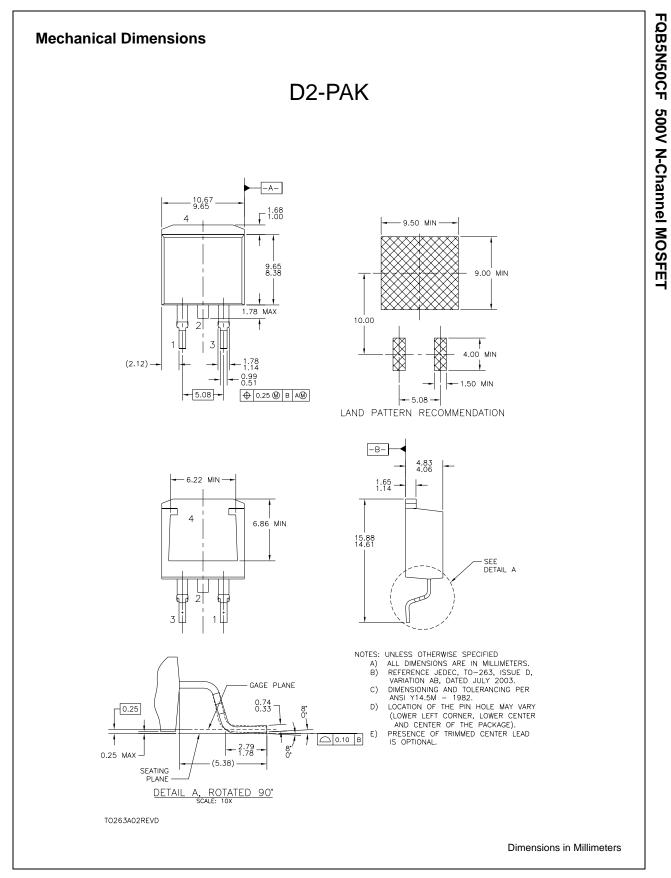
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